

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
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APPLICANT
Yoshiki ICHIOKA et al.FILING DATE
September 26, 2001

GROUP 2874

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JDL	AA	5,528,389	6/18/96	Nuss	359	4	
	AB						
	AC						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	INT. CLASS	INT. SUBCLASS	TRANSLATION YES NO	
JDL	AD	11-46304	2/16/99	JP	H04N	1/41		X
JDL	AE	5-100256	4/23/93	JP	G02F	1/35		X
JDL	AF	5-72047	3/23/93	JP	C01J	11/00		X
	AG							
	AH							

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

JDL	AI	J. Opt. Soc. Am.A, Vol. 14, No. 5 (May 1997), P.C.Sun, Y.T. Mazurenko, Y. Fainman, "Femtosecond pulse imaging: ultrafast optical oscilloscope", pp. 1159-1170.
JDL	AJ	PROCEEDING OF SPIE, Vol 3137 (July 1997), Photorefractive Fiber and Crystal Devices: Materials, Optical Properties, and Applications, Yoshiki Ichioka, Tsuyoshi Konishi, "Temporal-spatial optical information processing", pp. 222-227.
JDL	AK	Extended Abstracts, No. 3 (March, 1998), 45th Meeting of Ouyou Butsuri Gakkai Kankei Rengou, T. Konishi, Y. Oka, Y. Ichioka, "Jikuu kan Hikari Jouhou Shori: II-1 Jigen Jikan Shingou - 2 Jigen Kuukan Shingou Henkan", p. 993, 30p-C-1.
JDL	AM	Extended Abstracts, No. 3, 46th Meeting of Ouyou Butsuri Gakkai Kankei Rengou, (March 1999), T. Konishi, Y. Oka, Y. Ichioka, "Jikuu kan Hikari Jouhou Shori: VI-SHG Kesshou wo mochiita 1 Jigen Jikan Shingou - 2 Jigen Kuukan Shingou Henkan", p. 1073, 30p-V-1.
JDL	AN	Opt.Lett., Vol. 19, No. 9, (May 1, 1994, Martin C. Nuss, Melissa Li, T.H. Chiu, "Time-to-space mapping of femtosecond pulses", pp. 664-666.
	AO	

EXAMINER

John D. Lee

DATE CONSIDERED

27 OCTOBER 2005

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.